

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/911,155	PARIKH ET AL.	
Examiner		Shouxiang Hu	Art Unit	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	American Institute of Physics Handbook, pages 9-172-9-177, 1982
	V	Denisenko et al., Device Research Conference, Denver, CO, USA, pages 75-76, June 2000.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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